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Application/Control No.	Applicant(s)/Patent under Reexamination
10/769,765	AOTO ET AL.
Examiner	Art Unit
Shih-wen Hsieh	2861

	SEARCHED		
Class	Subclass	Date	Examiner
347	68,70-72	11/17/2005	imvo SWH
428	· 697	11/17/2005	\$WH
438	3,240	11/17/2005	sWH*
501	134	11/17/2005	ś₩ħ
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	PUB text e attached)	11/17/2005	∕∕∕W® SWH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east text search (see attached)	11/16/2005	Must SWH
consulted with stephen stein (AU 1775)	1/16/2005	ANWS SWH
consulted with crystal feggins (au 2861)	11/17/2005	SWH SWH
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